	TOT DDIOD.	*DT-01791	ATTY. DOCKET NO.		APPLN. SERIAL NO. -09/514,250			
ri91	OF PRIOR APPLIC	\sim A NITT/ \sim	APPLICANT(S) Ho Young CHOI et al.					
(PTO-1449) (PTO-1449)				FILING DATE February 28, 2000		GROUP 2872		
		S	Sepanten d	OCUMENTS			X -10	
EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE		*INVENTOR NAME		SUBCLASS	FILI DA	
<u> </u>								
					1			
Section (Section)		LIC DATE	VITE A DDI 10 A I	TON DIVINITION TO	ONG			X.25.3
Maria Maria	*PATENT	U.S. PATEI	NI APPLICAT	HON PUBLICATI	UNS			
	APPLN.		*APPI IOANIT		0,400	011001400		
	PUB. NO.	*PUB. DATE	*AF	PPLICANT	CLASS	SUBCLASS		
			U.S. PATENT AF	PLICATIONS				
	*APPLN. NO.	*FILING DATE		IVENTOR	CLASS	SUBCLASS		
			 OREIGN PATENT	POCUMENTS				
EXAMINER'S		F.					Trans	lation
INITIALS	PATENT NO	DATE		OUNTRY	CLASS	SUBCLASS	Yes	No
/r	6-331941	04/22/1997	Japan		-		X	
	4-361201	05/06/1997	Japan				X	
ļ <u>.</u>	4-214516	12/08/1992	Japan				X	
	57-108818	07/07/1982	Japan				X	
	62-278520	04/25/1989	Japan			1	X	
	3-276113	12/06/1991	Japan	·		_	X	
	6-331898	12/02/1994	Japan				X	<u> </u>
	6-347700	12/22/1994	Japan				X	ļ
	6-331887	12/02/1994	Japan				X	
	55-124114	09/25/1980	Japan				X	ļ
m	8-36131	02/06/1996	Japan			1 100 100 100 100 100 100 100 100 100 1	X	
TO	IER ART (Includi	ng Author, Ti	tle, Date, Perti	nent Pages, Publisl	ner, Place of	Publication,	Etc.)	
		/						
	 							
	-/-/-						·	
EVALUETO	- 	$\overline{}$	Г,	DATE CONCIDED	ED			
EXAMINER	/ /	~>>	1	DATE CONSIDER 2 /	ED と〜み _ ン	» Z		

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.